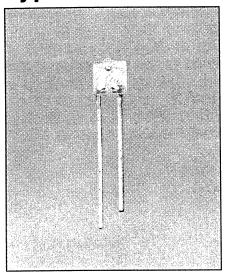
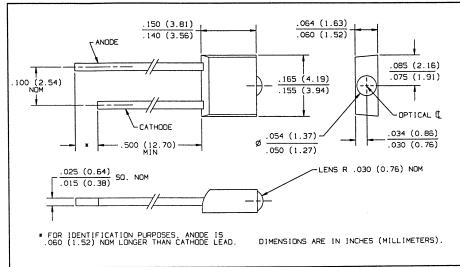


GaAs Plastic Infrared Emitting Diodes Types OP169A, OP169B, OP169C





Features

- · Integral lens for narrow beam angle
- Easily stackable on 0.100 inch (2.54 mm) hole centers
- Mechanically and spectrally matched to the OP509 phototransistor series

Description

The OP169 series are gallium arsenide infrared emitting diodes molded in "end looking" miniature clear packages. The molded lens insures improved uniformity of lens magnification from unit to unit. The OP169 series provides a broad range of on-line and radiant intensities and has considerable design flexibility due to its small size. These devices are mechanically and spectrally matched to the OP509 series phototransistors.

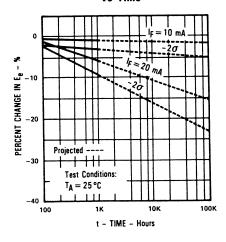
Absolute Maximum Ratings (T_A = 25° C unless otherwise noted)

| Continuous Forward Current | 50 mA |
|---|-------------------|
| Peak Forward Current (Pulse Width = 1 μsec, 300pps) | 3.0 A |
| Reverse Voltage | 2.0 V |
| Storage and Operating Temperature Range40° C to + | 100° C |
| Lead Soldering Temperature [1/16 inch (1.6mm) from case for 5 sec. with solde | ring |
| iron) 26 | 0, C(.) |
| Power Dissipation | mW ⁽²⁾ |
| Notes: | |

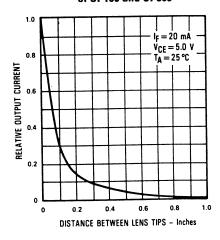
- (1) RMA flux is recommended. Duration can be extended to 10 seconds max. when flow soldering. Maximum 20 grams force may be applied to the leads when soldering. (2) Derate linearly 1.33 mW/° C above 25° C.
- (3) E_{e(APT)} is a measurement of the average apertured radiant incidence upon a sensing area 0.180" (4.57 mm) in diameter, perpendicular to and centered on the mechanical axis of the lens, and 0.653" (16.6 mm) from the lens tip. $E_{e(APT)}$ is a measurement of the average radiant intensity within the cone formed by the above conditions. Ee(APT) is not necessarily uniform within the measured area.

Typical Performance Curves

Percent Changes in Radiant Intensity vs Time



Coupling Characteristics of OP169 and OP509



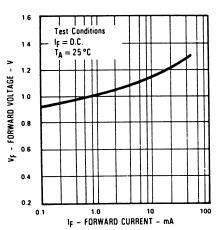
Types OP169A, OP169B, OP169C

Electrical Characteristics (T_A = 25° C unless otherwise noted)

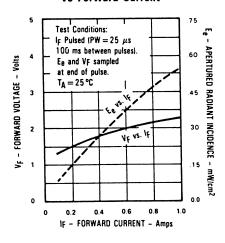
| SYMBOL | PARAMETER | | MIN | TYP | MAX | UNITS | TEST CONDITIONS | |
|---------------------|-------------------------------------|----------------------------|-------|-------|-------|--------------------|---------------------------------------|--|
| E _{e(APT)} | Apertured Radiant Incidence | OP169C OP169B OP169A | 0.108 | | 0.220 | mW/cm ² | I _F = 20 mA ⁽³⁾ | |
| VF | Forward Voltage | | | | 1.60 | V | I _F = 20 mA | |
| I _R | Reverse Current | | | | 100 | μА | V _R = 2.0 V | |
| λр | Wavelength at Peak Emission | | | 935 | | nm | I _F = 20 mA | |
| В | Bandwidth Between Half Power Points | | | 50 | | nm | I _F = 10 mA | |
| Δλρ/ΔΤ | Spectral Shift with Temperature | | | +0.30 | | nm/°C | I _F = Constant | |
| θнР | Emission Angle at Half Power Points | | | 46 | | Deg. | I _F = 20 mA | |
| tr | Output Rise Time | | | 1000 | | ns | I _{F(PK)} = 100 mA, | |
| tf | Output Fall Time | | | 500 | | ns | PW = 10 μs, D.C. = 10.0% | |



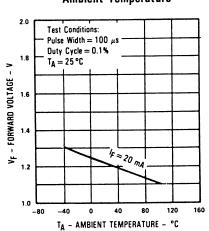
Forward Voltage vs Forward Current



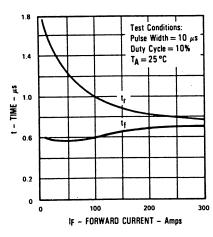
Forward Voltage and Radiant Incidence vs Forward Current



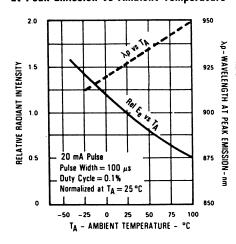
Forward Voltage vs Ambient Temperature



Rise Time and Fall Time vs Forward Current



Relative Radiant Intensity and Wavelength at Peak Emission vs Ambient Temperature



Relative Radiant Intensity vs Angular Displacement

